


Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/718,465		LEE ET AL.	
	Examiner		Art Unit	
	Dwayne J. White		3745	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
415		115			415	116				
INTERNATIONAL CLASSIFICATION					416	95	96R	97R		
F	0	3	D	11/00						
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<i>Dwayne J. White</i> Dwayne White (5/27/05) (Assistant Examiner) (Date)		<i>Edward K. Look</i> 5/31/05 EDWARD K. LOOK SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3700 (Priamary Examiner) (Date)		Total Claims Allowed: 25 O.G. Print Claim(s) O.G. Print Fig. 1 1	
<i>K. Cooper</i> 5/31/05 (Legal Instruments Examiner) (Date)					

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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